# Advanced Micro Devices

# Am27C512

# 512 Kilobit (65,536 x 8-Bit) CMOS EPROM

# **DISTINCTIVE CHARACTERISTICS**

- Fast access time
  - 70 ns
- **■** Low power consumption
  - 20 μA typical CMOS standby current
- JEDEC-approved pinout
- Single +5 V power supply
- **■** ±10% power supply tolerance available
- 100% Flashrite<sup>TM</sup> programming
  - Typical programming time of 8 seconds

- Latch-up protected to 100 mA from −1 V to Vcc + 1 V
- High noise immunity
- Versatile features for simple interfacing
  - Both CMOS and TTL input/output compatibility
  - Two line control functions
- Standard 28-pin DIP, PDIP, 32-pin TSOP, LCC and PLCC packages
- **DESC SMD No. 5962-87648**

#### GENERAL DESCRIPTION

The Am27C512 is a 512 K-bit ultraviolet erasable programmable read-only memory. It is organized as 64K words by 8 bits per word, operates from a single +5 V supply, has a static standby mode, and features fast single address location programming. Products are available in windowed ceramic DIP and LCC packages as well as plastic one time programmable (OTP) PDIP, TSOP and PLCC packages.

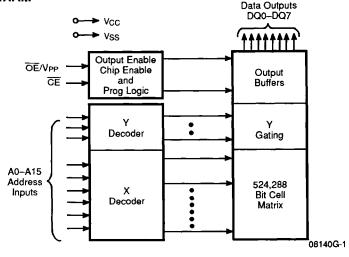
Typically, any byte can be accessed in less than 70 ns, allowing operation with high-performance microprocessors without any WAIT states. The Am27C512 offers separate Output Enable  $(\overline{OE})$  and Chip Enable  $(\overline{CE})$ 

controls, thus eliminating bus contention in a multiple bus microprocessor system.

AMD's CMOS process technology provides high speed, low power, and high noise immunity. Typical power consumption is only 80 mW in active mode, and 100  $\mu\text{W}$  in standby mode.

All signals are TTL levels, including programming signals. Bit locations may be programmed singly, in blocks, or at random. The Am27C512 supports AMD's Flashrite™ programming algorithm (100 µs pulses) resulting in a typical programming time of 8 seconds.

#### **BLOCK DIAGRAM**



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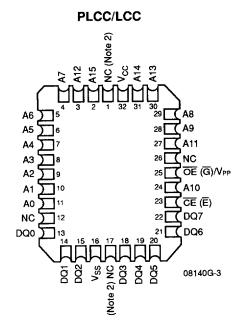
# PRODUCT SELECTOR GUIDE

| Family Part No.                           |     | Am27C512 |      |      |      |      |  |  |
|---|-----|----------|------|------|------|------|--|--|
| Ordering Part No:<br>V <sub>CC</sub> ± 5% | -75 |          |      |      |      | -255 |  |  |
| Vcc ± 10%                                 |     | -90      | -120 | -150 | -200 | -250 |  |  |
| Max Access Time (ns)                      | 70  | 90       | 120  | 150  | 200  | 250  |  |  |
| CE (E) Access Time (ns)                   | 70  | 90       | 120  | 150  | 200  | 250  |  |  |
| OE (G) Access Time (ns)                   | 40  | 40       | 50   | 50   | 75   | 100  |  |  |

## **CONNECTION DIAGRAMS**

**Top View** 

DIP 28 Vcc A15 L A12 27 A14 26 A13 А7 П 3 25 A8 A6 🛛 24 A9 A5 [] A4 [] 23 A11 22 A3 [] OE (G)/VPP 21 A10 A2 🛚 A1 [] 9 20 CE (E) A0 1 10 19 DQ7 DQ0 **□** 11 18 DQ6 17 **П** DQ5 DQ1 12 13 16 DQ4 DQ2 4 DQ3 15 Vss 08140G-2



#### Notes:

- 1. JEDEC nomenclature is in parentheses.
- 2. Don't use (DU) for PLCC.

#### PIN DESIGNATIONS

A0-A15 = Address Inputs

\overline{\text{CE}}(\overline{\text{E}}) = Chip Enable Input

DQ0-DQ7 = Data Inputs/Outputs

DU = No External Connection
(Do Not Use)

NC = No Internal Connection

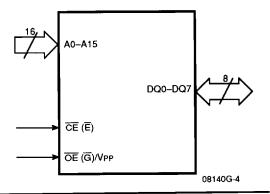
 $\overline{OE}$   $(\overline{G})/V_{PP}$  = Output Enable Input/

Program Supply Voltage

V<sub>CC</sub> = V<sub>CC</sub> Supply Voltage

Vss = Ground

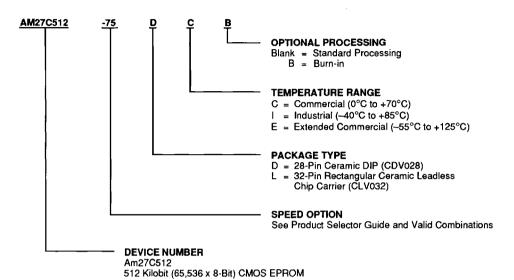
#### LOGIC SYMBOL



#### **ORDERING INFORMATION**

#### **EPROM Products**

AMD Standard products are available in several packages and operating ranges. The order number (Valid Combination) is formed by a combination of:



| Valid Combinations |                   |  |  |  |  |  |  |
|--------------------|-------------------|--|--|--|--|--|--|
| AM27C512-75        | DC, DCB, LC, LCB  |  |  |  |  |  |  |
| AM27C512-90        |                   |  |  |  |  |  |  |
| AM27C512-120       | DC, DCB, DI, DIB, |  |  |  |  |  |  |
| AM27C512-150       | DE, DEB, LC, LCB, |  |  |  |  |  |  |
| AM27C512-200       | LI. LIB. LE. LEB  |  |  |  |  |  |  |
| AM27C512-250       |                   |  |  |  |  |  |  |
| AM27C512-255       | 1                 |  |  |  |  |  |  |

#### **Valid Combinations**

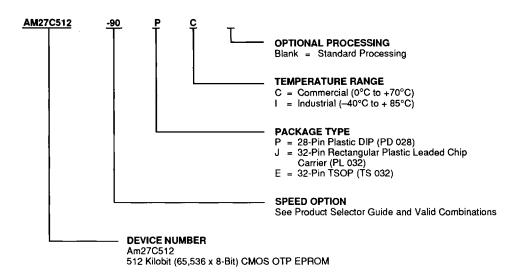
Valid Combinations list configurations planned to be supported in volume for this device. Consult the local AMD sales office to confirm availability of specific valid combinations and to check on newly released combinations.



# **ORDERING INFORMATION**

#### **OTP Products**

AMD Standard products are available in several packages and operating ranges. The order number (Valid Combination) is formed by a combination of:



| Valid Combinations |                          |  |  |  |  |  |
|--------------------|--------------------------|--|--|--|--|--|
| AM27C512-90        |                          |  |  |  |  |  |
| AM27C512-120       |                          |  |  |  |  |  |
| AM27C512-150       | PC, JC, EC<br>PI, JI, EI |  |  |  |  |  |
| AM27C512-200       | P1, J1, E1               |  |  |  |  |  |
| AM27C512-255       |                          |  |  |  |  |  |

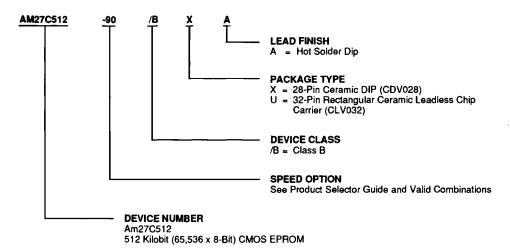
#### **Valid Combinations**

Valid Combinations list configurations planned to be supported in volume for this device. Consult the local AMD sales office to confirm availability of specific valid combinations and to check on newly released combinations.

# **ORDERING INFORMATION**

# **Military APL Products**

AMD products for Aerospace and Defense applications are available in several packages and operating ranges. APL (Approved Products List) products are fully compliant with MIL-STD-883 requirements. The order number (Valid Combination) is formed by a combination of:



| Valid Combinations |            |  |  |  |
|--------------------|------------|--|--|--|
| AM27C512-90        |            |  |  |  |
| AM27C512-120       |            |  |  |  |
| AM27C512-150       | /BXA, /BUA |  |  |  |
| AM27C512-200       |            |  |  |  |
| AM27C512-250       |            |  |  |  |

#### **Valid Combinations**

Valid Combinations list configurations planned to be supported in volume for this device. Consult the local AMD sales office to confirm availability of specific valid combinations and to check on newly released combinations.

#### **Group A Tests**

Group A tests consist of Subgroups 1, 2, 3, 7, 8, 9, 10, 11.

# **FUNCTIONAL DESCRIPTION**

#### Erasing the Am27C512

In order to clear all locations of their programmed contents, it is necessary to expose the Am27C512 to an ultraviolet light source. A dosage of 15 W seconds/cm² is required to completely erase an Am27C512. This dosage can be obtained by exposure to an ultraviolet lamp—wavelength of 2537 Å—with intensity of 12,000  $\mu\text{W/cm}^2\text{for 15 to 20 minutes}.$  The Am27C512 should be directly under and about one inch from the source and all filters should be removed from the UV light source prior to erasure.

It is important to note that the Am27C512 and similar devices will erase with light sources having wavelengths shorter than 4000 Å. Although erasure times will be much longer than with UV sources at 2537 Å, exposure to fluorescent light and sunlight will eventually erase the Am27C512 and exposure to them should be prevented to realize maximum system reliability. If used in such an environment, the package window should be covered by an opaque label or substance.

# Programming the Am27C512

Upon delivery or after each erasure the Am27C512 has all 524,288 bits in the "ONE" or HIGH state. "ZEROs" are loaded into the Am27C512 through the procedure of programming.

The programming mode is entered when 12.75 V  $\pm$  0.25 V is applied to the  $\overline{OE}/V_{PP}$  and  $\overline{CE}$  is at  $V_{IL}$ .

For programming, the data to be programmed is applied 8 bits in parallel to the data output pins.

The Flashrite algorithm reduces programming time by using 100  $\mu s$  programming pulses and by giving each address only as many pulses as is necessary in order to reliably program the data. After each pulse is applied to a given address, the data in that address is verified. If the data does not verify, additional pulses are given until it verifies or the maximum is reached. This process is repeated while sequencing through each address of the Am27C512. This part of the algorithm is done at  $V_{CC}=6.25$  V to assure that each EPROM bit is programmed to a sufficiently high threshold voltage. After the final address is completed, the entire EPROM memory is verified at  $V_{CC}=5.25$  V.

Please refer to Section 6 for programming flow chart and characteristics.

#### Program Inhibit

Programming of multiple Am27C512 in parallel with different data is also easily accomplished. Except for  $\overline{CE}$ , all like inputs of the parallel Am27C512 may be common. A TTL low-level program pulse applied to an Am27C512  $\overline{CE}$  input and  $\overline{OE}/V_{PP} = 12.75$  V  $\pm$  0.25 V, will program that Am27C512. A high-level  $\overline{CE}$  input

inhibits the other Am27C512 devices from being programmed.

### **Program Verify**

A verify should be performed on the programmed bits to determine that they were correctly programmed. The verify should be performed with  $\overline{\text{CE}}$  at  $V_{\text{IL}}$  and  $\overline{\text{OE}}/V_{\text{PP}}$  at  $V_{\text{IL}}$ . Data should be verified  $t_{\text{DV}}$  after the falling edge of  $\overline{\text{CE}}$ .

#### **Auto Select Mode**

The auto select mode allows the reading out of a binary code from an EPROM that will identify its manufacturer and type. This mode is intended for use by programming equipment for the purpose of automatically matching the device to be programmed with its corresponding programming algorithm. This mode is functional in the  $25^{\circ}\text{C} \pm 5^{\circ}\text{C}$  ambient temperature range that is required when programming the Am27C512.

To activate this mode, the programming equipment must force 12.0  $\pm$  0.5 V on address line A9 of the Am27C512. Two identifier bytes may then be sequenced from the device outputs by toggling address line A0 from V<sub>IL</sub> to V<sub>IH</sub>. All other address lines must be held at V<sub>IL</sub> during auto select mode.

Byte 0 (A0 =  $V_{IL}$ ) represents the manufacturer code, and byte 1 (A0 =  $V_{IH}$ ), the device code. For the Am27C512, these two identifier bytes are given in the Mode Select Table. All identifiers for manufacturer and device codes will possess odd parity, with the MSB (DQ7) defined as the parity bit.

#### **Read Mode**

The Am27C512 has two control functions, both of which must be logically satisfied in order to obtain data at the outputs. Chip Enable  $(\overline{CE})$  is the power control and should be used for device selection. Output Enable  $(\overline{OE}/V_{PP})$  is the output control and should be used to gate data to the output pins, independent of device selection. Assuming that addresses are stable, address access time (tacc) is equal to the delay from  $\overline{CE}$  to output (tce). Data is available at the outputs toe after the falling edge of  $\overline{OE}/V_{PP}$ , assuming that  $\overline{CE}$  has been LOW and addresses have been stable for at least tacc—toe.

### Standby Mode

The Am27C512 has a CMOS standby mode which reduces the maximum Vcc current to 100  $\mu$ A. It is placed in CMOS-standby when  $\overline{CE}$  is at Vcc  $\pm$  0.3 V. The Am27C512 also has a TTL-standby mode which reduces the maximum Vcc current to 1.0 mA. It is placed in TTL-standby when  $\overline{CE}$  is at V<sub>IH</sub>. When in standby mode, the outputs are in a high-impedance state, independent of the  $\overline{OE}$  input.

# **Output OR-Tieing**

To accommodate multiple memory connections, a twoline control function is provided to allow for:

- Low memory power dissipation
- Assurance that output bus contention will not occur It is recommended that  $\overline{CE}$  be decoded and used as the primary device-selecting function, while  $\overline{OE}/V_{PP}$  be made a common connection to all devices in the array and connected to the READ line from the system control bus. This assures that all deselected memory devices are in low-power standby mode and that the output pins are only active when data is desired from a particular memory device.

#### System Applications

During the switch between active and standby conditions, transient current peaks are produced on the rising and falling edges of Chip Enable. The magnitude of these transient current peaks is dependent on the output capacitance loading of the device. At a minimum, a 0.1- $\mu$ F ceramic capacitor (high frequency, low inherent inductance) should be used on each device between Vcc and Vss to minimize transient effects. In addition, to overcome the voltage drop caused by the inductive effects of the printed circuit board traces on EPROM arrays, a 4.7- $\mu$ F bulk electrolytic capacitor should be used between Vcc and Vss for each eight devices. The location of the capacitor should be close to where the power supply is connected to the array.

#### **MODE SELECT TABLE**

| Mode            | Pins                 | CE          | ŌĒ/Vpp | Α0  | A9 | Outputs |
|-----------------|----------------------|-------------|--------|-----|----|---------|
| Read            |                      | ViL         | VIL    | Х   | Х  | Dout    |
| Output Disable  |                      | Х           | ViH    | Х   | Х  | Hi-Z    |
| Standby (TTL)   |                      | Vін         | Х      | х   | х  | Hi-Z    |
| Standby (CMOS)  |                      | Vcc + 0.3 V | х      | Х   | Х  | Hi-Z    |
| Program         |                      | VIL         | Vpp    | Х   | х  | Din     |
| Program Verify  |                      | Vil         | VIL    | х   | х  | Dout    |
| Program Inhibit |                      | ViH         | Vpp    | X   | х  | Hi-Z    |
| Auto Select     | Manufacturer<br>Code | VIL         | ViL    | VIL | VH | 01H     |
| (Note 3)        | Device Code          | VıL         | VIL    | ViH | VH | 91H     |

#### Notes:

- 1.  $V_H = 12.0 \pm 0.5 V$
- 2. X = Either VIH or VIL
- 3. A1-A8 = A10-A15 = VIL
- 4. See DC Programming Characteristics for VPP voltage during programming.



#### **ABSOLUTE MAXIMUM RATINGS**

| Storage Temperature OTP Products65°C to +125°C All Other Products65°C to +150°C |
|---|
| Ambient Temperature with Power Applied –55°C to +125°C                          |
| Voltage with Respect To V <sub>SS</sub> All pins except A9,                     |
| V <sub>PP</sub> ,V <sub>CC</sub> 0.6 V to V <sub>CC</sub> + 0.5 V               |
| A9 and V <sub>PP</sub> 0.6 V to +13.5 V   |
| Vcc0.6 V to +7.0 V  |

#### Notes:

- Minimum DC voltage on input or I/O pins is -0.5 V. During transitions, the inputs may overshoot Vss to -2.0 V for periods of up to 20 ns. Maximum DC voltage on input and I/O pins is Vcc + 0.5 V which may overshoot to Vcc + 2.0 V for periods up to 20 ns.
- For A9 and V<sub>PP</sub> the minimum DC input is -0.5 V. During transitions, A9 and V<sub>PP</sub> may overshoot V<sub>SS</sub> to -2.0 V for periods of up to 20 ns. A9 and V<sub>PP</sub> must not exceed 13.5 V for any period of time.

Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure of the device to absolute maximum rating conditions for extended periods may affect device reliability.

# **OPERATING RANGES**

| Commercial (C) Devices  Case Temperature (Tc)            | 0°C to +70°C                |
|--|-----------------------------|
| Industrial (I) Devices  Case Temperature (Tc)            | 40°C to +85°C               |
| Extended Commercial (E) D<br>Case Temperature (Tc)       |                             |
| Military (M) Devices  Case Temperature (T <sub>C</sub> ) | 55°C to +125°C              |
| Supply Read Voltages Vcc for Am27C512-XX5                | +4.75 V to +5.25 V          |
| V <sub>CC</sub> for Am27C512-XX0                         | +4.50 V to +5.50 V          |
| Operating ranges define these liv                        | nite hatwaan which the func |

Operating ranges define those limits between which the functionality of the device is guaranteed.

# DC CHARACTERISTICS over operating range unless otherwise specified. (Notes 1, 2 and 4) (for APL Products, Group A, Subgroups 1, 2, 3, 7 and 8 are tested unless otherwise noted)

| Parameter<br>Symbol | Parameter Description          | Test Conditions                            | Min         | Max       | Unit |    |
|---------------------|--------------------------------|--|-------------|-----------|------|----|
| Vон                 | Output HIGH Voltage            | loн = -400 μA                              |             | 2.4       |      |    |
| VoL                 | Output LOW Voltage             | loL = 2.1 mA                               |             |           | 0.45 | ٧  |
| ViH                 | Input HIGH Voltage             |  | 2.0         | Vcc + 0.5 | ٧    |    |
| VIL                 | Input LOW Voltage              |  | -0.5        | +0.8      | ٧    |    |
| lu                  | Input Load Current             | Vin = 0 V to +Vcc                          | -           | 1.0       | μА   |    |
| • -                 |                                |  | C/I Devices |           | 1.0  |    |
| llo                 | Output Leakage Current         | Vout = 0 V to +Vcc                         | E/M Devices |           | 5.0  | μА |
| ICC1                | Vcc Active Current<br>(Note 3) | CE = V <sub>IL</sub> , f = 10 MHz,         |             | 30        | mA   |    |
| lcc2                | Vcc TTL Standby Current        | CE = VIH                                   |             | 1.0       | mĀ   |    |
| lcc3                | Vcc CMOS Standby Current       | $\overline{CE} = V_{CC} \pm 0.3 \text{ V}$ |             | 100       | μА   |    |

#### Notes:

- 1. VCC must be applied simultaneously or before VPP, and removed simultaneously or after VPP.
- 2. Caution: The Am27C512 must not be removed from (or inserted into) a socket when V<sub>CC</sub> or V<sub>PP</sub> is applied.
- 3.  $I_{CC1}$  is tested with  $\overline{OE}/V_{PP} = V_{IH}$  to simulate open outputs.
- 4. Minimum DC Input Voltage is -0.5 V. During transitions, the inputs may overshoot to -2.0 V for periods less than 20 ns. Maximum DC Voltage on output pins is Vcc + 0.5 V, which may overshoot to Vcc + 2.0 V for periods less than 20 ns.

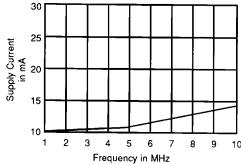


Figure 1. Typical Supply Current vs. Frequency Vcc = 5.5 V, T = 25°C

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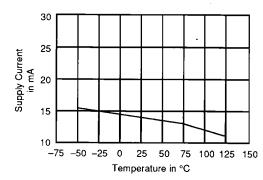


Figure 2. Typical Supply Current vs. Temperature
Vcc = 5.5 V, f = 10 MHz

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#### CAPACITANCE

| Parameter |                       | Test       | CL\ | /032    | CD  | CDV028 |     | /028 PL |     | 032 | PD 028 |  |  |
|-----------|-----------------------|------------|-----|---------|-----|--------|-----|---------|-----|-----|--------|--|--|
| Symbol    | Parameter Description | Conditions | Тур | Typ Max | Тур | Max    | Тур | Max     | Тур | Max | Unit   |  |  |
| Cin       | Input Capacitance     | VIN = 0    | 9   | 12      | 10  | 12     | 9   | 12      | 6   | 10  | рF     |  |  |
| Соит      | Output Capacitance    | Vout = 0   | 10  | 12      | 10  | 13     | 9   | 12      | 6   | 10  | рF     |  |  |

#### Notes:

- This parameter is only sampled and not 100% tested.
- 2. TA = +25°C, f = 1 MHz

# SWITCHING CHARACTERISTICS over operating range unless otherwise specified (Notes 1, 3, 4 and 5) (for APL Products, Group A, Subgroups 9,10, and 11 are tested unless otherwise noted)

| Parameter<br>Symbols |                 |   |                    |            |         |         | Am2      | 7C512    |          |              |      |
|----------------------|-----------------|---|--------------------|------------|---------|---------|----------|----------|----------|--------------|------|
| JEDEC                | Standard        | Parameter<br>Description  | Test<br>Conditions | •          | -75     | -90     | -120     | -150     | -200     | -255<br>-250 | Unit |
| tavov                | tacc            | Address to<br>Output Delay  | CE = OE =<br>VIL   | Min<br>Max | <br>70  | -<br>90 | -<br>120 | -<br>150 | 200      | _<br>250     | ns   |
| tELQV                | tce             | Chip Enable to<br>Output Delay  | OE = Vil           | Min<br>Max | _<br>70 | -<br>90 | _<br>120 | _<br>150 | -<br>200 | _<br>250     | ns   |
| tGLQV                | toe             | Output Enable to<br>Output Delay  | CE = VIL           | Min<br>Max | -<br>40 | -<br>40 | _<br>50  | -<br>50  | -<br>75  | -<br>75      | ns   |
| tehaz<br>tehaz       | tDF<br>(Note 2) | Chip Enable HIGH or<br>Output Enable HIGH,<br>whichever comes<br>first, to Output Float |                    | Min<br>Max | _<br>25 | 30      | 30       | 30       | 30       | 30           | ns   |
| taxox                | toH             | Output Hold from<br>Addresses, CE,<br>or OE, whichever<br>occurred first                |                    | Min<br>Max | 0 -     | 0 -     | 0        | 0 -      | 0_       | 0            | ns   |

#### Notes:

- 1. VCC must be applied simultaneously or before Vpp, and removed simultaneously or after Vpp.
- 2. This parameter is only sampled and not 100% tested.
- 3. Caution: The Am27C512 must not be removed from (or inserted into) a socket or board when Vpp or Vcc is applied.
- 4. Output Load: 1 TTL gate and CL = 100 pF

Input Rise and Fall Times: 20 ns

Input Pulse Levels: 0.45 V to 2.4 V

Timing Measurement Reference Level: 0.8 V and 2 V inputs and outputs

5. For the Am27C512-75:

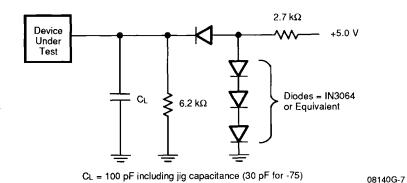
Output Load: 1 TTL gate and  $C_L = 30 pF$ 

Input Rise and Fall Times: 20 ns

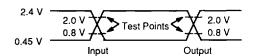
Input Pulse Levels: 0 V to 3 V

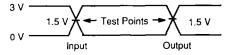
Timing Measurement Reference Level: 1.5 V for inputs and outputs

# **SWITCHING TEST CIRCUIT**



# SWITCHING TEST WAVEFORM





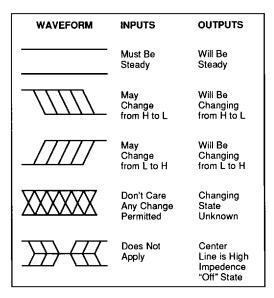
08140G-8

AC Testing: Inputs are driven at 2.4 V for a logic "1" and 0.45 V for a logic "0". Input pulse rise and fall times are ≤ 20 ns.

AC Testing: Inputs are driven at 3.0 V for a logic "1" and 0 V for a logic "0". Input pulse rise and fall times are ≤ 20 ns for -75 device.

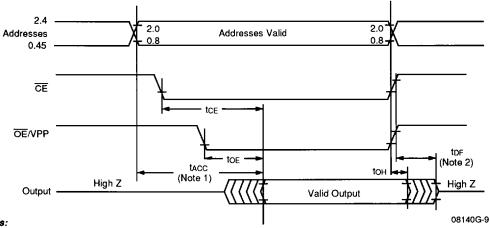


#### **KEY TO SWITCHING WAVEFORMS**



KS000010

# **SWITCHING WAVEFORMS**



#### Notes:

- 1.  $\overline{OE}/VPP$  may be delayed up to tACC tOE after the falling edge of the addresses without impact on tACC.
- 2. tDF is specified from  $\overline{OE}$  or  $\overline{CE}$ , whichever occurs first.